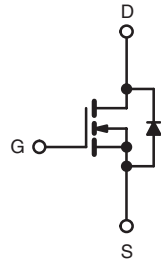
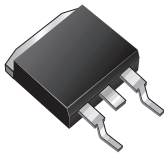


Power MOSFET

PRODUCT SUMMARY

| | | |
|---------------------------|-----------------------|------|
| V_{DS} (V) | 100 | |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 5\text{ V}$ | 0.27 |
| Q_g (Max.) (nC) | 12 | |
| Q_{gs} (nC) | 3.0 | |
| Q_{gd} (nC) | 7.1 | |
| Configuration | Single | |

SMD-220


N-Channel MOSFET

FEATURES

- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4\text{ V}$ and 5 V
- 175°C Operating Temperature

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION

| | |
|---------|----------|
| Package | SMD-220 |
| SnPb | IRL520S |
| | SiHL520S |

ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$, unless otherwise noted

| PARAMETER | SYMBOL | LIMIT | UNIT |
|--|-----------------|---------------------------|---------------------|
| Drain-Source Voltage | V_{DS} | 100 | V |
| Gate-Source Voltage | V_{GS} | ± 10 | |
| Continuous Drain Current | V_{GS} at 5 V | $T_C = 25^\circ\text{C}$ | 9.2 |
| | | $T_C = 100^\circ\text{C}$ | |
| Pulsed Drain Current ^a | I_{DM} | 36 | A |
| Linear Derating Factor | | 0.40 | W/ $^\circ\text{C}$ |
| Linear Derating Factor (PCB Mount) ^e | | 0.025 | |
| Single Pulse Avalanche Energy ^b | E_{AS} | 170 | mJ |
| Avalanche Current ^a | I_{AR} | 9.2 | A |
| Repetitive Avalanche Energy ^a | E_{AR} | 6.0 | mJ |
| Maximum Power Dissipation | P_D | $T_C = 25^\circ\text{C}$ | 60 |
| Maximum Power Dissipation (PCB Mount) ^e | | $T_A = 25^\circ\text{C}$ | 3.7 |
| Peak Diode Recovery dV/dt^c | dV/dt | 5.5 | V/ns |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | - 55 to + 175 | $^\circ\text{C}$ |
| Soldering Recommendations (Peak Temperature) | for 10 s | 300 ^d | |

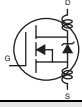
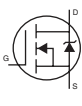
Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 25\text{ V}$, starting $T_J = 25^\circ\text{C}$, $L = 3.0\text{ mH}$, $R_G = 25\ \Omega$, $I_{AS} = 9.2\text{ A}$ (see fig. 12).
- $I_{SD} \leq 9.2\text{ A}$, $dI/dt \leq 110\text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 175^\circ\text{C}$.
- 1.6 mm from case.
- When mounted on 1" square PCB (FR-4 or G-10 material).

| THERMAL RESISTANCE RATINGS | | | | |
|--|------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R_{thJA} | - | 62 | °C/W |
| Maximum Junction-to-Ambient (PCB Mount) ^a | R_{thJA} | - | 40 | |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | 2.5 | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted | | | | | | | |
|--|---------------------|--|---|------|------|---------------------|----|
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. UNIT | |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | | 100 | - | - V | |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$, $I_D = 1\text{ mA}$ | | - | 0.12 | - V/°C | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | | 1.0 | - | 2.0 V | |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 10\text{ V}$ | | - | - | $\pm 100\text{ nA}$ | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}$ | | - | - | 25 μA | |
| | | $V_{DS} = 80\text{ V}, V_{GS} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$ | | - | - | 250 μA | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = 5\text{ V}$ | $I_D = 5.5\text{ A}^b$ | - | - | 0.27 Ω | |
| | | $V_{GS} = 4\text{ V}$ | $I_D = 4.6\text{ A}^b$ | - | - | 0.38 Ω | |
| Forward Transconductance | g_{fs} | $V_{DS} = 50\text{ V}, I_D = 5.5\text{ A}^b$ | | 3.2 | - | - S | |
| Dynamic | | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$, see fig. 5 | | - | 490 | - | |
| Output Capacitance | C_{oss} | | | - | 150 | - | pF |
| Reverse Transfer Capacitance | C_{riss} | | | - | 30 | - | |
| Total Gate Charge | Q_g | $V_{GS} = 5\text{ V}$ | $I_D = 9.2\text{ A}, V_{DS} = 80\text{ V}$, see fig. 6 and 13 ^b | - | - | 12 | |
| Gate-Source Charge | Q_{gs} | | | - | - | 3.0 | nC |
| Gate-Drain Charge | Q_{gd} | | | - | - | 7.1 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 50\text{ V}, I_D = 9.2\text{ A}, R_G = 9\text{ }\Omega, R_D = 5.2\text{ }\Omega$, see fig. 10 ^b | | - | 9.8 | - | |
| Rise Time | t_r | | | - | 64 | - | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | | - | 21 | - | |
| Fall Time | t_f | | | - | 27 | - | |
| Dynamic | | | | | | | |
| Internal Drain Inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact  | - | 4.5 | - | nH | |
| Internal Source Inductance | L_S | | - | 7.5 | - | | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | 9.2 | A | |
| Pulsed Diode Forward Current ^a | I_{SM} | | - | - | 36 | | |
| Body Diode Voltage | V_{SD} | $T_J = 25\text{ }^\circ\text{C}, I_S = 9.2\text{ A}, V_{GS} = 0\text{ V}^b$ | | - | - | 2.5 V | |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = 9.2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}^b$ | | - | 130 | 190 ns | |
| Body Diode Reverse Recovery Charge | Q_{rr} | | | - | 0.83 | 1.0 μC | |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

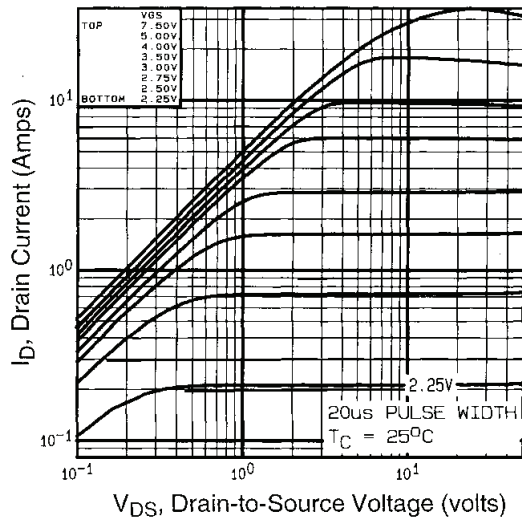


Fig. 1 - Typical Output Characteristics, $T_C = 25\text{ }^\circ\text{C}$

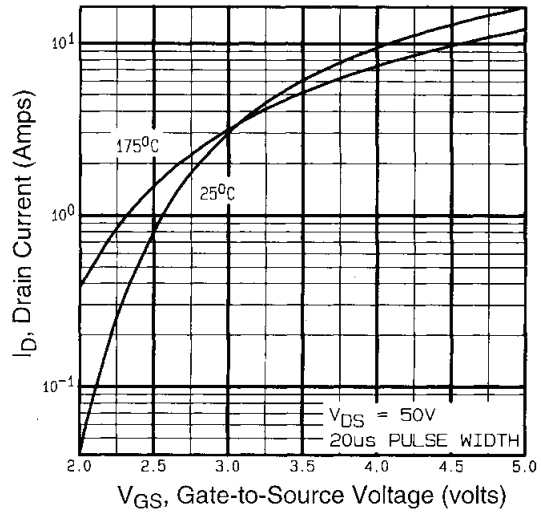


Fig. 3 - Typical Transfer Characteristics

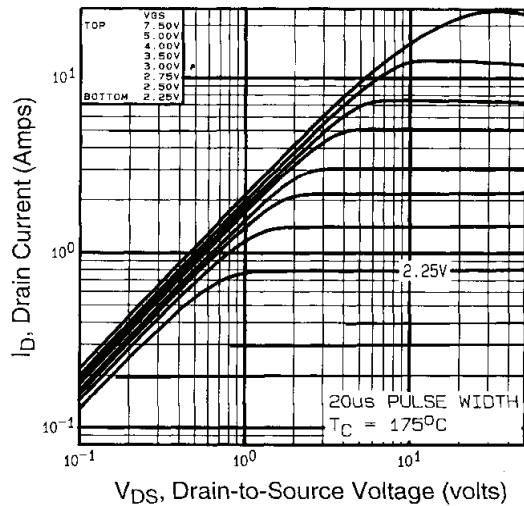


Fig. 2 - Typical Output Characteristics, $T_C = 150\text{ }^\circ\text{C}$

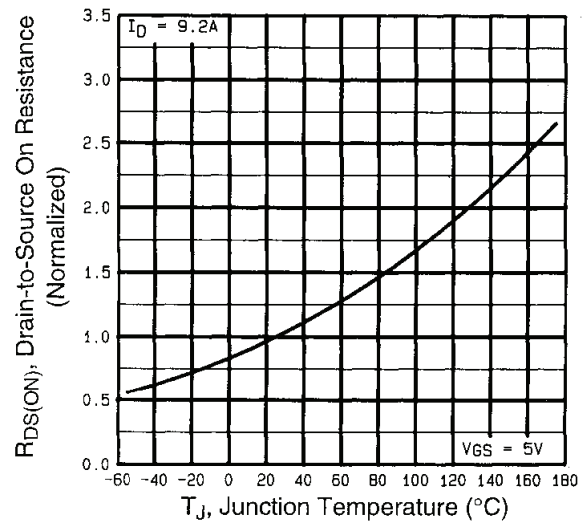


Fig. 4 - Normalized On-Resistance vs. Temperature

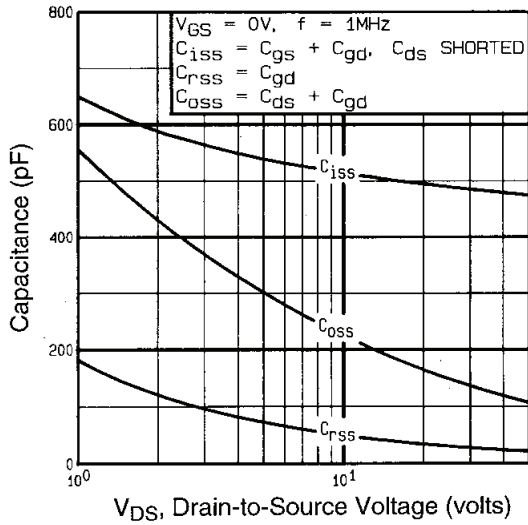


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

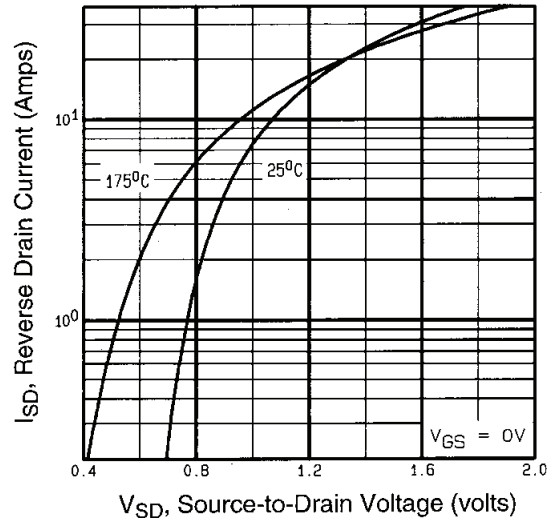


Fig. 7 - Typical Source-Drain Diode Forward Voltage

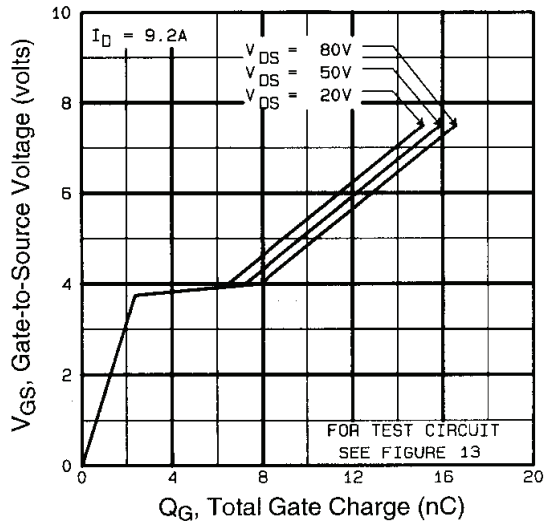


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

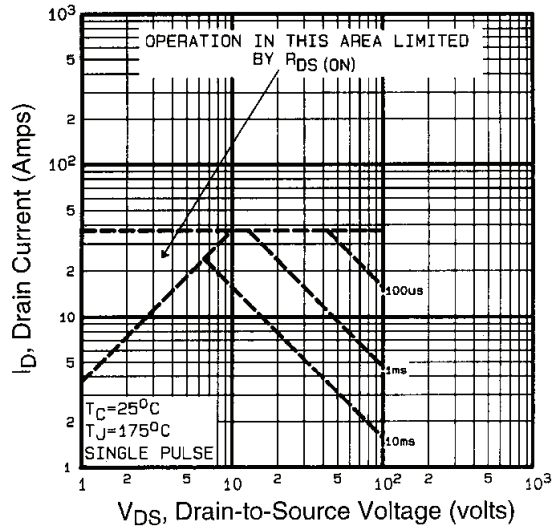


Fig. 8 - Maximum Safe Operating Area

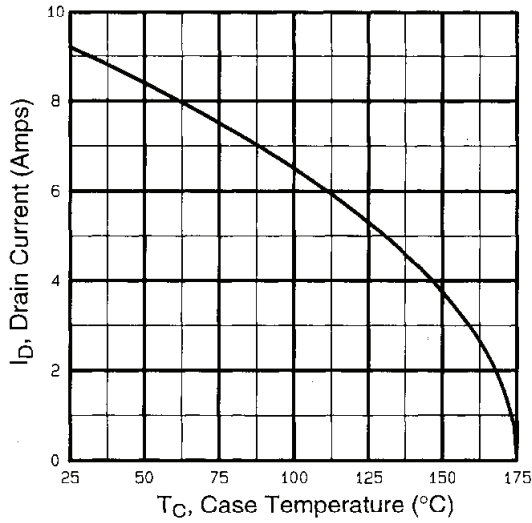


Fig. 9 - Maximum Drain Current vs. Case Temperature

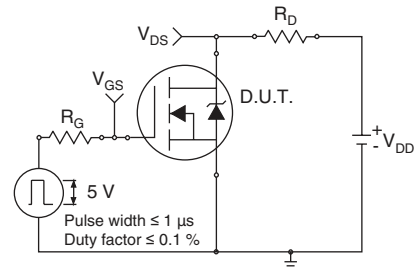


Fig. 10a - Switching Time Test Circuit

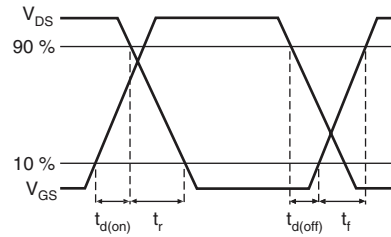


Fig. 10b - Switching Time Waveforms

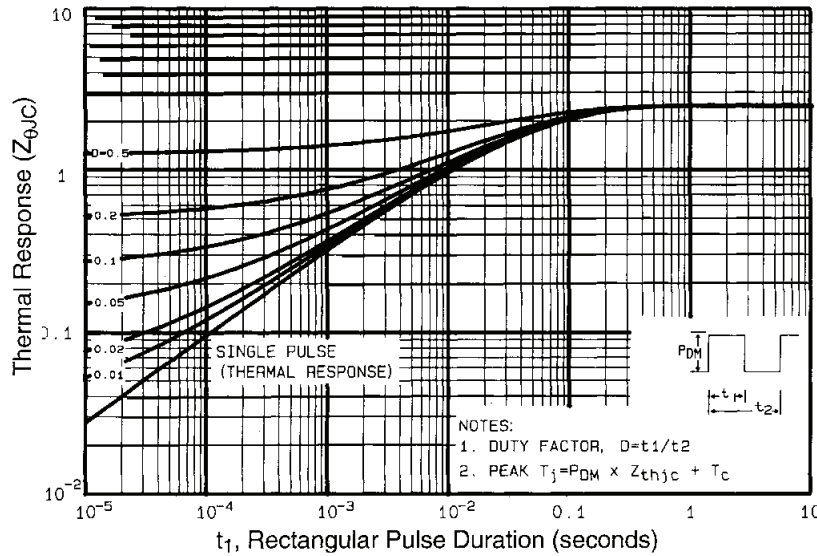


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

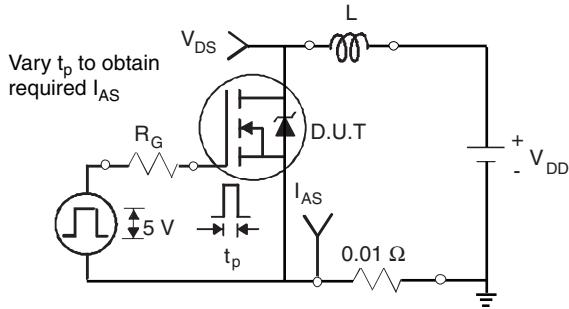


Fig. 12a - Unclamped Inductive Test Circuit



Fig. 12b - Unclamped Inductive Waveforms

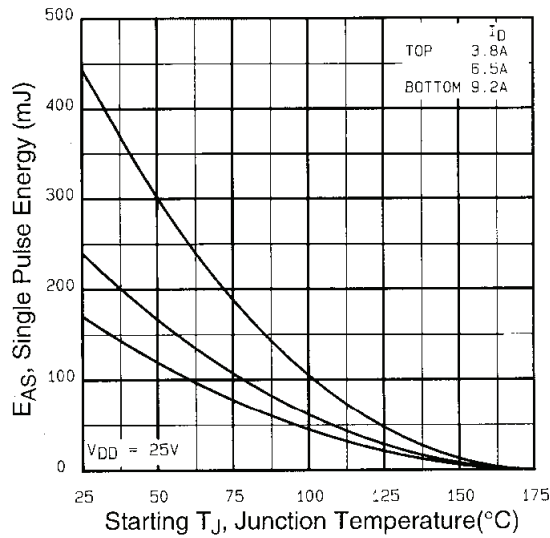


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

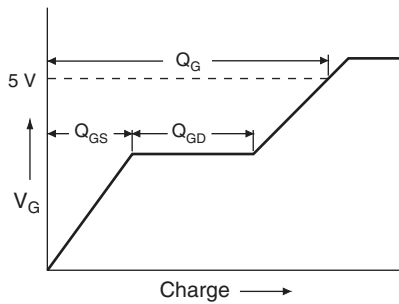


Fig. 13a - Basic Gate Charge Waveform

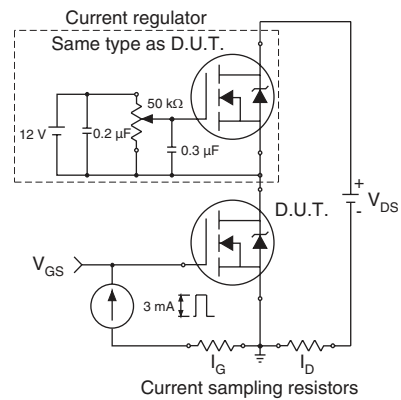
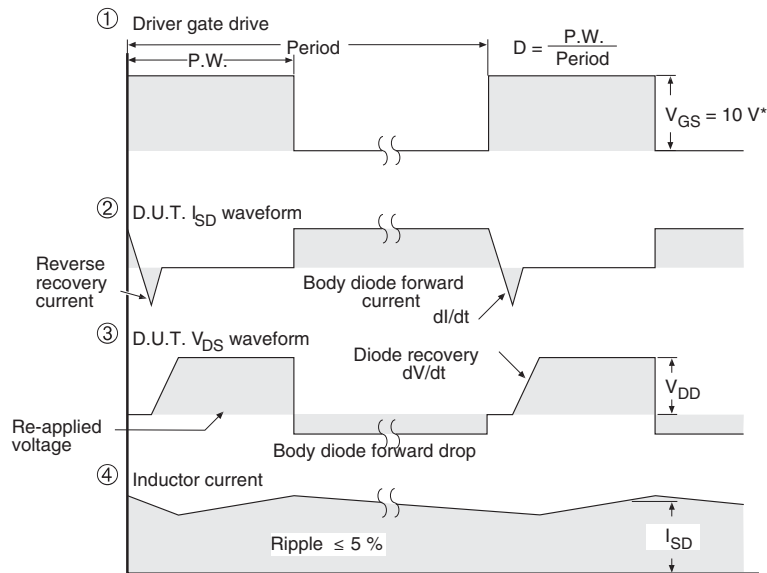
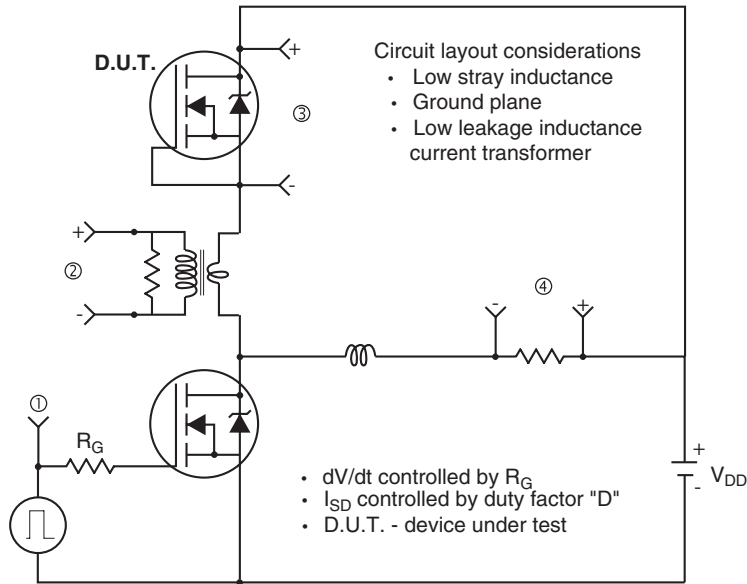


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5 V$ for logic level and $3 V$ drive devices

Fig. 14 - For N-Channel

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